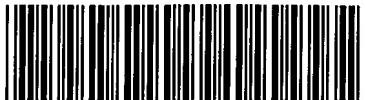


## **Search Notes**



**Application/Control No.**

10/058,658

Examiner

Richard Lee

**Applicant(s)/Patent under  
Reexamination**

POLLACK, MICHAEL J.

## **Art Unit**

2621

**SEARCHED**

**SEARCHED**

## **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**

## **INTERFERENCE SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner